

Motivation



- Power consumption in a superconducting cavity is proportional to its surface resistance R_S
- R_S shows a complex behavior on external parameters, such as temperature, frequency, magnetic and electric field

$$P_{\rm c} \propto R_{\rm S}(f,T,B,E)$$

- Some open questions:
 - Origin of the residual resistance
 - Origin of the field-dependent resistance
 - Stronger field-dependent resistance of niobium films compared to bulk niobium
 - Influence of magnetic and electric field
 - Relation to the surface properties
 - Possibilities and limitations of materials other than niobium

Motivation



PhD Project 1 - Sarah Aull (Univ. Siegen):
RF characterization of samples over a wide parameter range using a Quadrupole Resonator to test surface resistance models on different materials

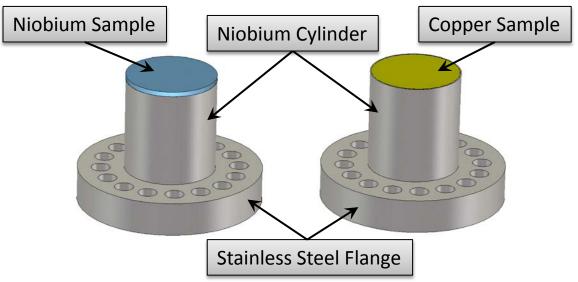
PhD Project 2 - Giovanni Terenziani (Univ. Sheffield):
Develop High Power Impulse Magnetron Sputtering
(HIPIMS) coatings to overcome limitations of standard
Direct Current Magnetron Sputtering (DCMS) coatings



Design of the Quadrupole Resonator



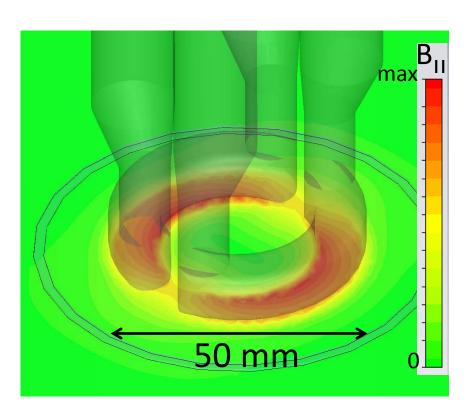
361 mm



- Sample diameter: 75 mm
- The sample needs to be EBwelded to the sample cylinder
- Bulk niobium and copper samples are available

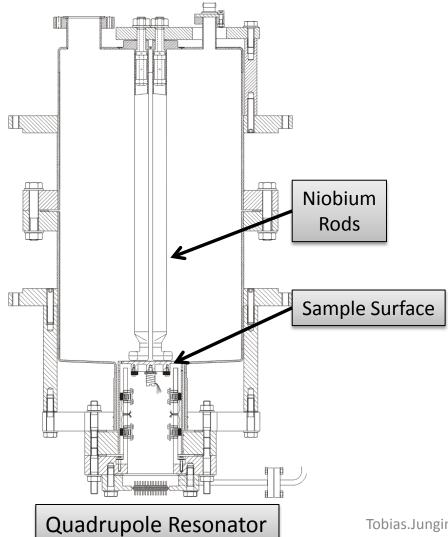
Field Configuration & Features



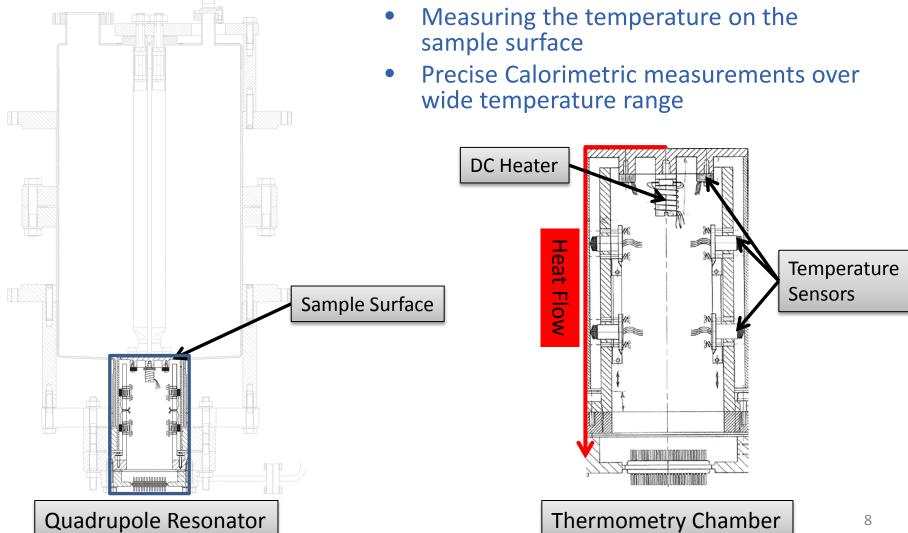


- Resonant frequencies:
 400, 800, 1200 MHz
- Almost identical magnetic field configuration
- Ratio between peak magnetic and electric field proportional to frequency

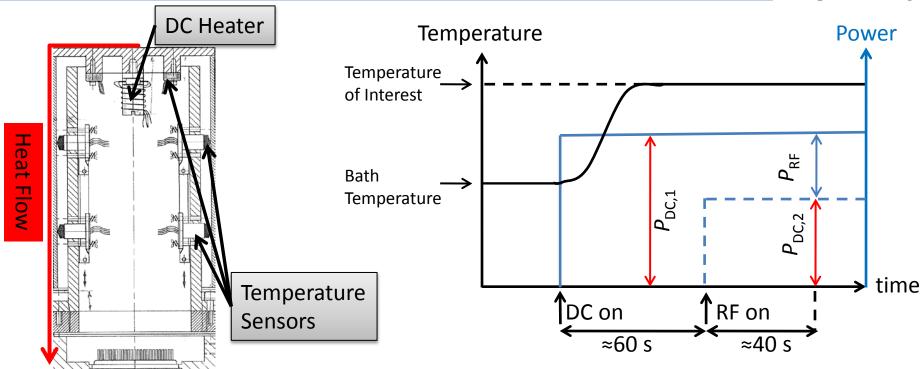








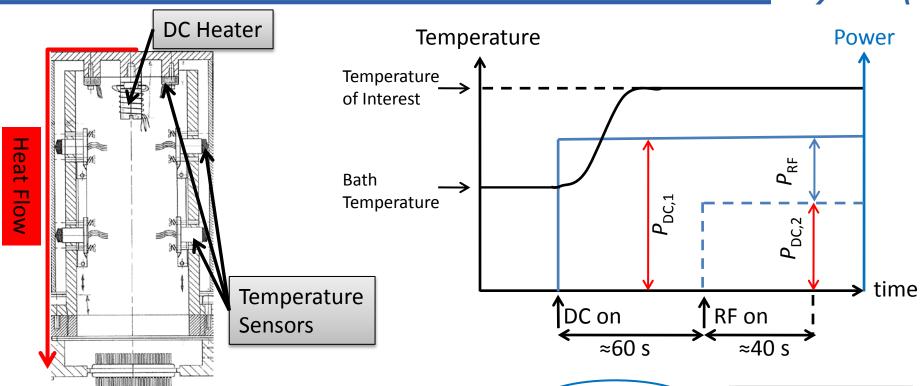




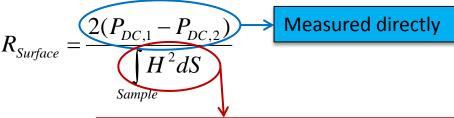
$$P_{RF} = P_{DC,1} - P_{DC,2} \approx 1/2 R_{Surface} \int_{Sample} H^2 dS$$

$$R_{Surface} = \frac{2(P_{DC,1} - P_{DC,2})}{\int_{Sample} H^2 dS}$$





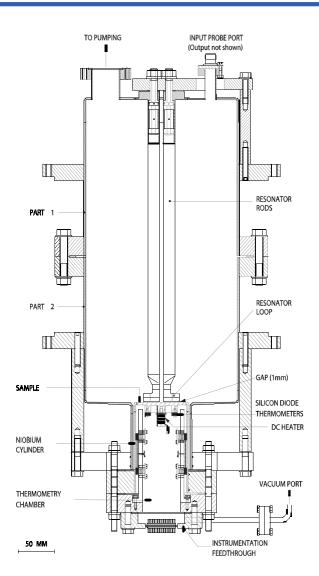
$$P_{RF} = P_{DC,1} - P_{DC,2} \approx 1/2 R_{Surface} \int_{Sample} H^2 dS$$



- Measurement of transmitted power P_t
- $P_t = c \int H^2 ds$, c from computer code

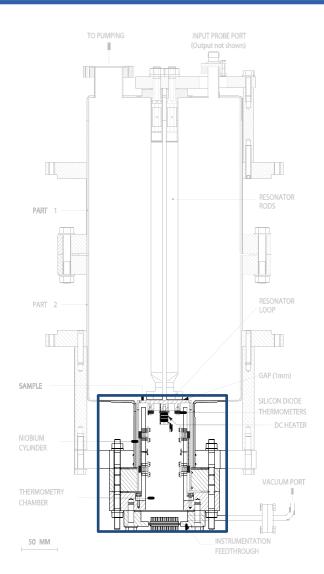
Flux Trapping

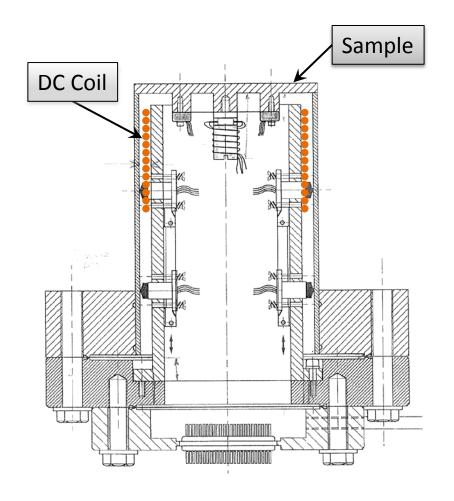




Flux Trapping

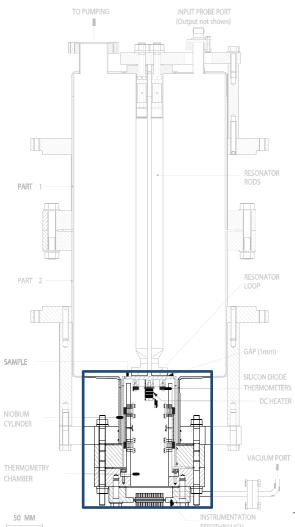


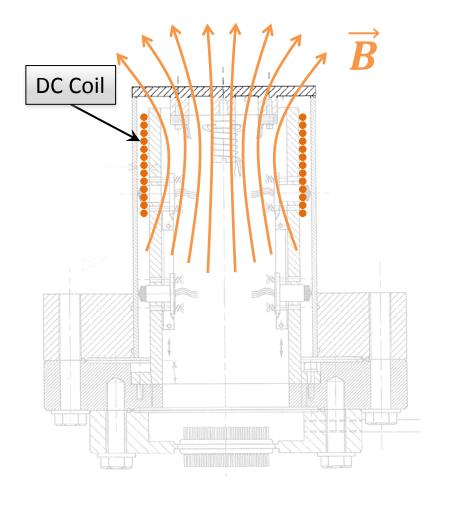




Flux Trapping







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Trapped Flux at 400MHz and 4K

20

10

20

30

Surface Resistance at 4.0K and 400MHz 50 no trapped flux ⊢ quadratic fit quadratic fit 45 quadratic fit 40 Surface Resistance [nΩ] 35 Bulk niobium sample 30 Reactor grade, RRR ≈ 65 Standard BCP, no bake out 25 $R_{res} \cong 11.5 \text{ n}\Omega$

40

Peak RF Magnetic Field [mT]

50

70

60

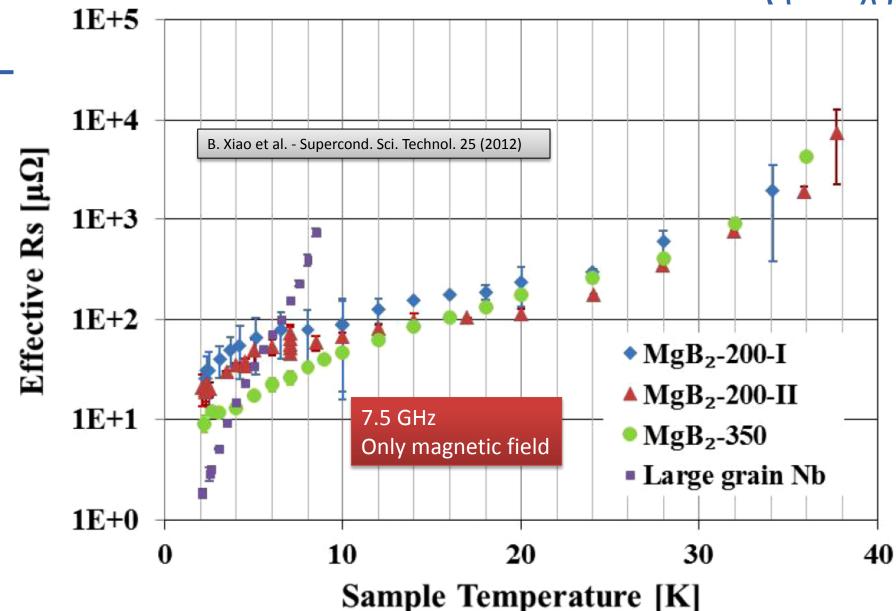
Magnesiumdiboride MgB₂



Material	Bulk Niobium	MgB ₂
R _{res}	A few nΩ	?
dR/dT (theoretically well understood)	Lowest for all elements	Better
dR/dB	Lowest increase, best studied material	So far worse, very few measurements
B _{c1}	Close to Bc ≈ 200 mT	Worse
B _{sh}	Above Bc	Better

Magnesium diboride MgB₂

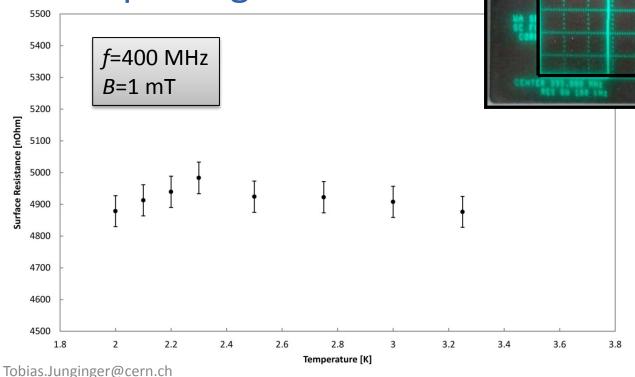


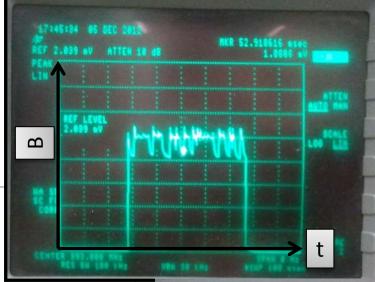


Magnesiumdiboride MgB₂

 Barrier in transmitted power above 1.3 mT

Multipacting?







Quadrupole Resonator - Summary and Outlook



- Sample tests over a parameter range inaccessible to elliptical cavities:
 - Three different RF frequencies, with almost identical magnetic field configuration
 - Frequency dependent electric field configuration
 - Wide temperature range
 - Accuracy of about $0.05 \text{ n}\Omega$
 - Study the influence of trapped magnetic flux
 - → Unique possibilities to test surface resistance models and study new materials
- Next sample to be tested: Niobium on Copper deposited by HIPIMS technology

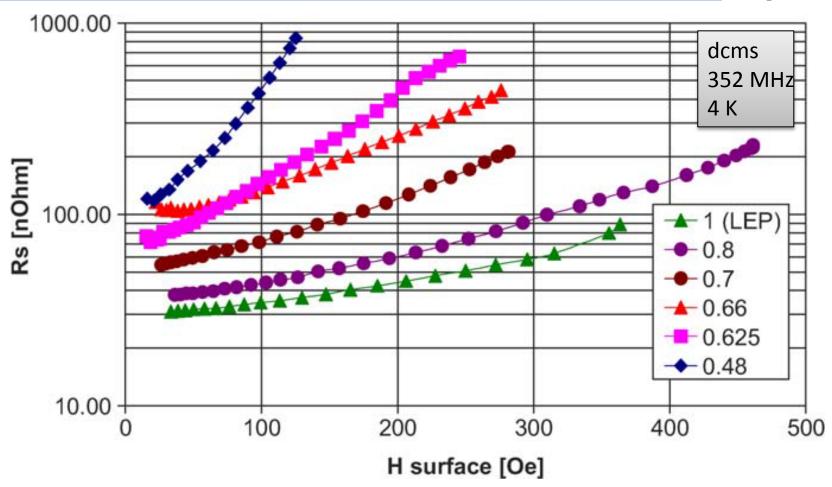
Lessons learned with sputtered films



- 288 Nb/Cu cavities installed in LEP
- 16 Nb/Cu cavities installed in LHC
- About 300 coatings on 1.5 GHz for R&D
- Low-beta studies, several 10's of coatings
- Advantages of films
 - Lower losses at 4.2 K and moderate accelerating gradient compared to bulk niobium
 - Reduced sensitivity to earth magnetic field, x100 less than bulk Nb: no need for magnetic shielding
 - Cheaper material
- Major disadvantage of films
 - Steep R_s increase with RF field

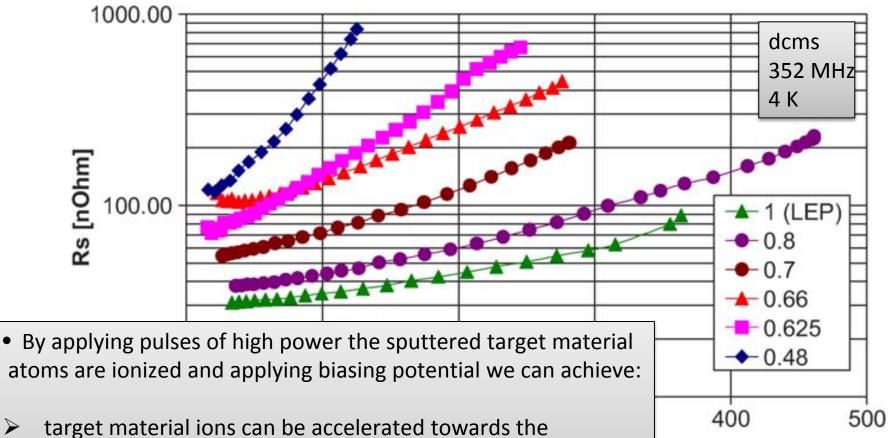
From dcms to HIPIMS





From dcms to HIPIMS



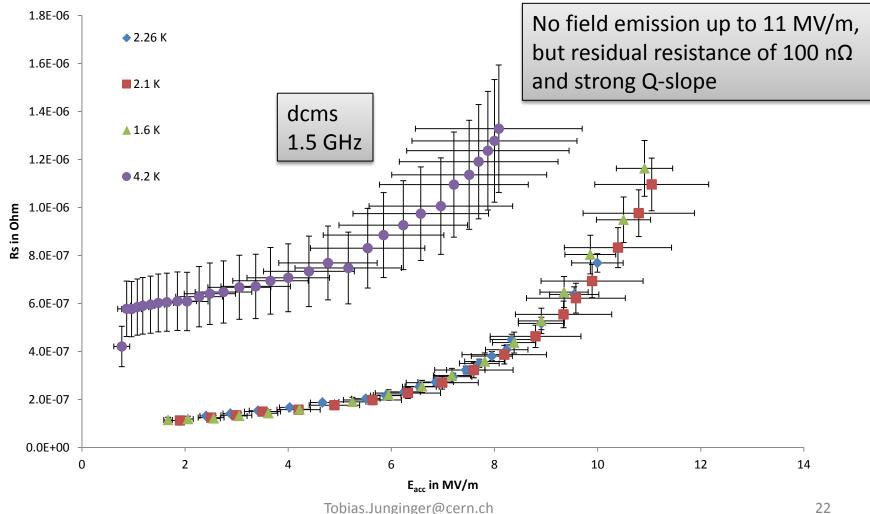


ions are directed to the surface, thus non-flat surfaces can be sputtered with good uniformity of the film

substrate, higher kinetic energy upon arrival

Reproducing old dcms results









Is the residual resistance caused by uncoated areas?

 $R_{\rm S}$ of copper at 1.5 GHz is about 1 m Ω $R_{\rm res}$ =100 n Ω

$$R_{\text{Res}} = R_{\text{N}} \frac{\text{Uncoated Surface Area}}{\text{Total Surface Area}}$$
?

Total Surface Area=670 cm2

→ Uncoated surface area=6.7 mm2

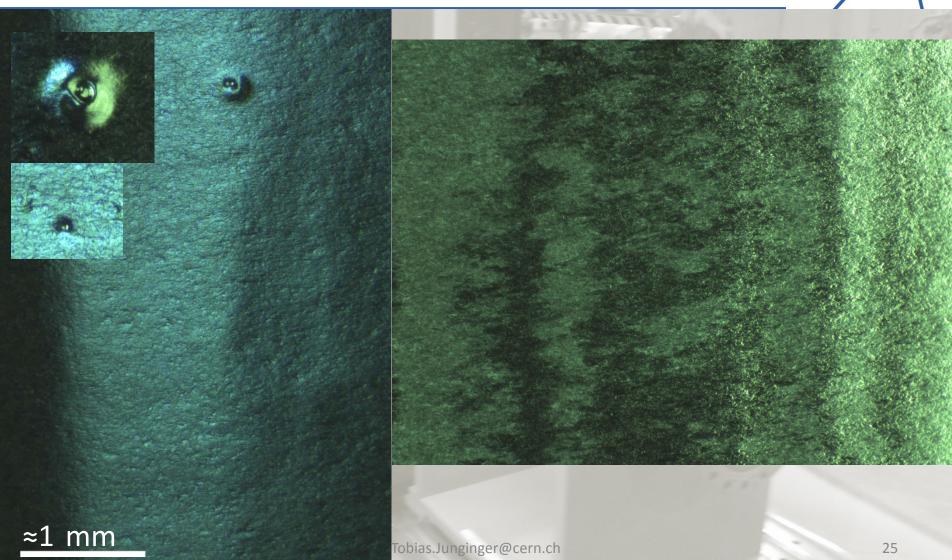
Should be detectable with optical inspection system

Optical Inspection



Optical Inspection





Acknowledgement



- Quadrupole Resonator: S. Aull, S. Doebert, J. Knobloch
- Coating of cavities: G. Terenziani, S. Calatroni, A. P. Ehiasarian
- Optical Inspection: Janic Chambrillon

After 50 years of experience with superconducting cavities, we are approaching the fundamental limitations of niobium by recipes for which the underlying physics is not completely understood. For some accelerator applications SRF technology is the only choice. For reliable production, building compacter machines and cheaper electricity bills basic R&D and material studies are necessary!